

**Notice of References Cited**

Application/Control No.

09/706,116

Applicant(s)/Patent Under  
Reexamination  
NARUSHIMA ET AL.

Examiner

Jean W. Désir

Art Unit

2614

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,366,359 B1	04-2002	Garland, Harry T.	358/1.15
	B	US-6,529,522 B1	03-2003	Ito et al.	370/466
	C	US-4,635,132	01-1987	Nakamura, Shunichi	358/296
	D	US-4,626,926	12-1986	Nakamura, Shunichi	358/296
	E	US-5,111,285 A	05-1992	Fujita et al.	358/500
	F	US-5,636,315	06-1997	Sugiyama et al.	386/46
	G	US-6,457,079 B1	09-2002	Hanaoka et al.	710/105
	H	US-6,456,714 B2	09-2002	Shima et al.	379/399.01
	I	US-6,298,405 B1	10-2001	Ito et al.	710/107
	J	US-6,493,874 B2	12-2002	Humpleman, Richard	725/78
	K	US-6,480,630 B1	11-2002	Kondo, Tetsujiro	382/240
	L	US-6,481,010 B2	11-2002	Nishikawa et al.	725/44
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.